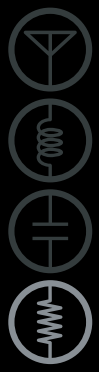
Innovative Service Around the Globe YAGEO

DATA SHEET

CHIP RESISTORS ARRAY

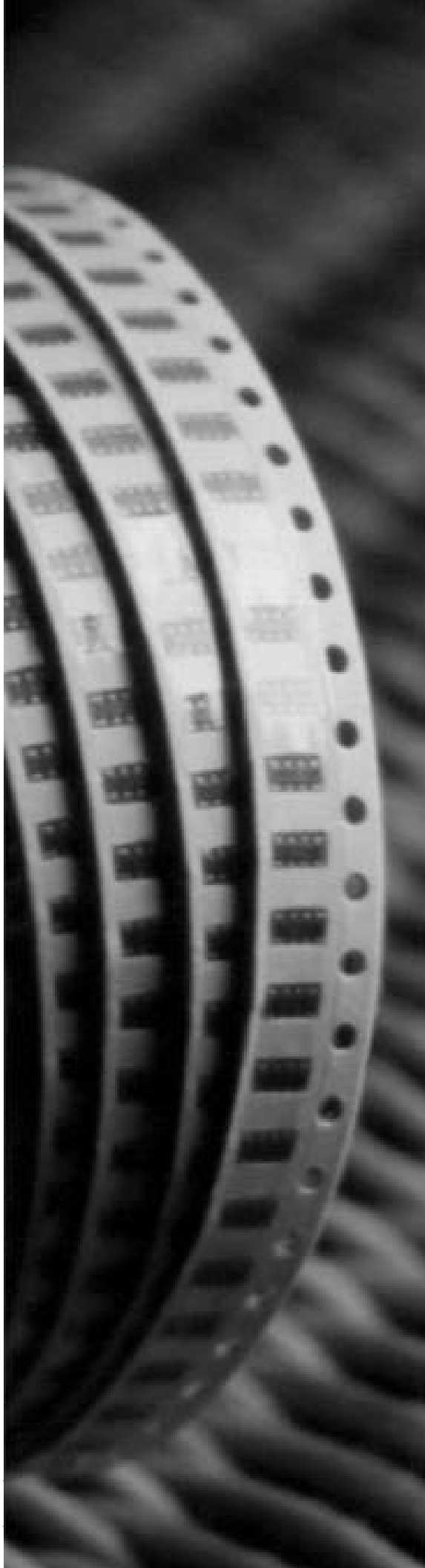
YC164 (8Pin/4R)

5%; 1%



YAGEO

Product Specification - Dec. 20, 2002 V.03 Supersedes Date of Jun. 04, 2002



SCOPE

This specification describes YC164 series chip resistors made by thick film process.

ORDERING INFORMATION

Part number is identified by the series, size, tolerance, packing style, temperature coefficient, special type and resistance value.

YC164 – X X X XX XXXX
(1) (2) (3) (4) (5)

(1) TOLERANCE

F = ±1%
J = ±5%

(2) PACKAGING TYPE

R = Paper taping reel

(3) TEMPERATURE CHARACTERISTIC OF RESISTANCE

G = ±200ppm/°C
– = Base on spec

(4) SPECIAL TYPE

07 = 7 inch dia. Reel

(5) RESISTANCE VALUE:

5R6, 56R, 560R, 5K6, 56K, 56M.

MARKING

YC164

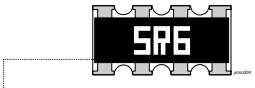


Fig. 1 5% Marking, Value=5.6Ω

First two digits for significant figure and 3rd digit for number of zeros

Letter R: decimal place

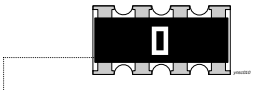


Fig. 2 Jumper=Zero Ohm

Letter 0: Jumper chip (0 ohm)

DIMENSION

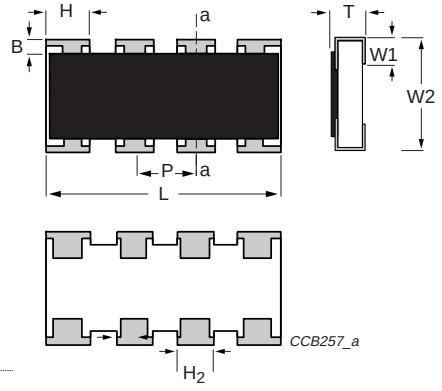


Fig. 3 YC164 series chip resistors construction

Table 1

TYPE	YC164
B (mm)	0.3±0.15
H (mm)	0.65±0.05
P (mm)	0.8±0.05
L (mm)	3.2±0.15
H_2 (mm)	0.5±0.15
T (mm)	0.6±0.1
W_1 (mm)	0.3±0.15
W_2 (mm)	1.6±0.15

SCHEMATIC

For dimension see Fig. 3 and Table 1

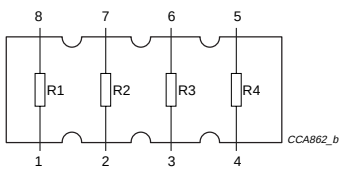


Fig. 4 Equivalent circuit diagram

R1=R2=R3=R4

POWER RATING

RATED POWER AT 70°C, YC164=1/16W FOR ELEMENT

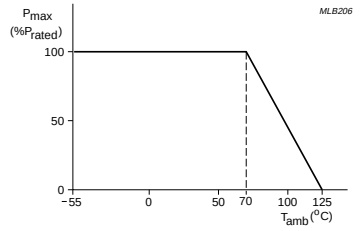


Fig. 5 Maximum dissipation (P_{max}) in percentage of rated power as a function of the operating ambient temperature (T_{amb})

RATED VOLTAGE:

The DC or AC (rms) continuous working voltage corresponding to the rated power is determined by the following formula:

$V=\sqrt{(P \times R)}$

Where

V=Continuous rated DC or AC (rms) working voltage (V)

P=Rated power (W)

R=Resistance value (Ω)

ELECTRICAL CHARACTERISTICS

Table 2

CHARACTERISTICS	YC164 1/16W
Operating Temperature Range	–55°C to +125°C
Maximum Working Voltage	50V
Maximum Overload Voltage	100V
Dielectric Withstanding Voltage	100V
Number of Resistors	4
Resistance Range	10Ω to 1MΩ
Temperature Coefficient	±200ppm/°C

TAPING REEL

Table 3

DIMENSION	YC164
Tape Width	8mm
ØA (mm)	180+0/–3
ØB (mm)	60+1/–0
ØC (mm)	13.0±0.2
ØD (mm)	21±0.8
W (mm)	9.0±0.3
T_{max} (mm)	11.4±1

For dimension see Table 3

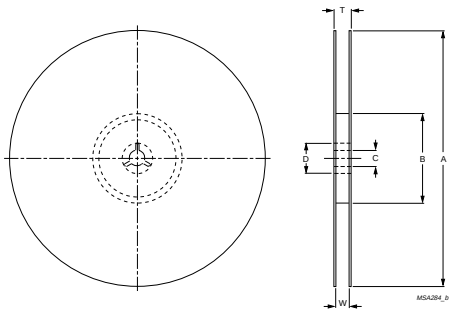


Fig. 6 Reel dimension

PAPER TAPE SPECIFICATION

Table 4

DIMENSION	YC164
A (mm)	2.0±0.1
B (mm)	3.5±0.1
W (mm)	8.0±0.2
E (mm)	1.75±0.1
F (mm)	3.5±0.05
P_0 (mm)	4.0±0.1
P_1 (mm)	4.0±0.1
P_2 (mm)	2.0±0.05
ØD_0 (mm)	1.5+0.1/–0
T_{max} (mm)	0.85±0.1

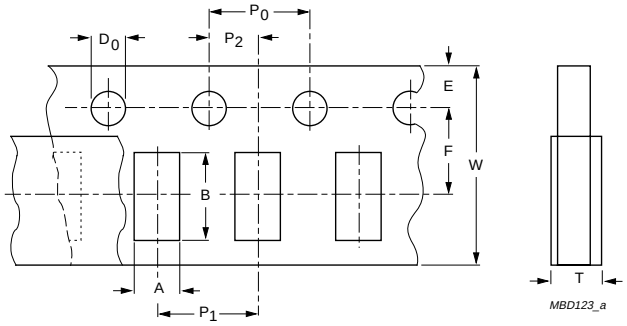


Fig.7 Paper tape dimension

For dimension see Table 4

PACKING METHOD

LEADER/TRAILER TAPE SPECIFICATION

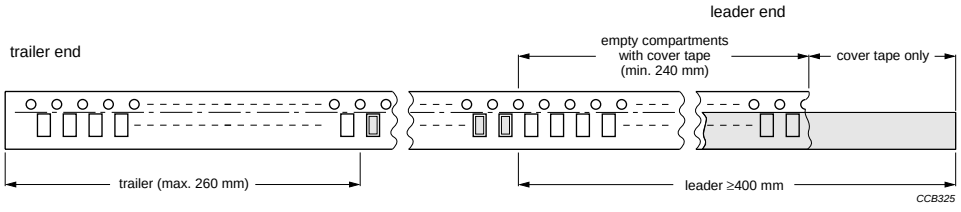


Fig. 8 Leader and trailer tape dimension

Table 5 Packing style and packaging quantity

PACKING STYLE	REEL DIMENSION	YC164
Paper Taping Reel (R)	7" (178 mm)	5,000

TYPE	TEST METHOD	ACCEPTANCE STANDARD
Temperature Coefficient of Resistance (T.C.R.)	Measure resistance at +25°C or specified room temperature as R_1, then measure at –55°C or +125°C respectively as R_2. Determine the temperature coefficient of resistance from the following formula: **Formula** $T.C.R. = \frac{R_2 - R_1}{R_1(t_2 - t_1)} \times 10^6$ (ppm/°C) Where t_1=+25°C or specified room temperature t_2=–55°C or +125°C test temperature R_1=resistance at reference temperature in ohms R_2=resistance at test temperature in ohms	Refer to table 2
Thermal Shock	At –55±3°C for 2 minutes and at +125±2°C for 2 minutes as one cycle. After 5 cycles, the specimen shall be stabilized at room temp. Measure the resistance to determine ΔR/R(%) after one more hour.	±(1%+0.05Ω)
Low Temperature Operation	Place the specimen in a test chamber maintained at –65 (+0/–5)°C. After one hour stabilization at this temperature, full rated working voltage shall be applied for 45 (+5/–0) minutes. Have15 (+5/–0) minutes after remove the voltage, the specimen shall be removed from the chamber and stabilized at room temperature for 24 hrs. Measure the resistance to determine ΔR/R(%).	±(1.0%+0.05Ω) No visible damage
Short Time Overload	Apply 2.5 times of rated voltage but not exceeding the maximum overload voltage for 5 seconds. Have the specimen stabilized at room temperature for 30 minutes minimum. Measure the resistance to determine ΔR/R(%).	±(2.0%+0.05Ω) No visible damage
Insulation Resistance	Place the specimen in the jig and apply a rated continues overload voltage (R.C.O.V) for one minute as shown. Measure the insulation resistance. **Type: YC164 / Voltage: 100V**	≥10,000MΩ
Dielectric Withstand Voltage	Place the specimen in the jig and apply a specified value continuous overload voltage as shown for one minute. **Type: YC164 / Voltage: 100V**	Breakdown voltage> specification and without open/short
Resistance To Soldering Heat	Immerse the specimen in the solder pot at 260±5°C. for 10±1 seconds. Have the specimen stabilized at room temperature for 30 minutes minimum. Measure the resistance to determine ΔR/R(%).	±(1.0%+0.05Ω) No visible damage

TYPE	TEST METHOD	ACCEPTANCE STANDARD
Moisture Resistance	Place the specimen in the test chamber and subject to 42 damp heat cycles. Each one of which consists of the steps 1 to 7 as figure 10. The total length of test is 1,000 hours. Have the specimen stabilized at room temperature for 24 hours after testing. Measure the resistance to determine ΔR/R(%).	±(2.0%+0.05Ω) No visible damage
Life	Place the specimen in the oven at 70±2°C. Apply the rated voltage to the specimen at the 1.5 hours on and 0.5 hour off cycle. The total length of test is 1,000 hours. Have the specimen stabilized at room temperature for one hour minimum after testing. Measure the ΔR/R(%).	±(3%+0.1Ω) for 5% tolerance No visible damage
Solderability	Immerse the specimen in the solder pot at 230±5°C for 5 sec.	At least 95% solder coverage on the termination
Bending Strength	Mount the specimen on a test board as shown in the figure 9. Slowly apply the force till the board is bent for 5±1 sec. Measure the ΔR/R(%) at this position.	±(1.0%+0.05Ω) No visible damage

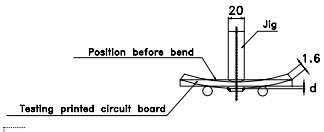


Fig. 9 Principle of the bending test

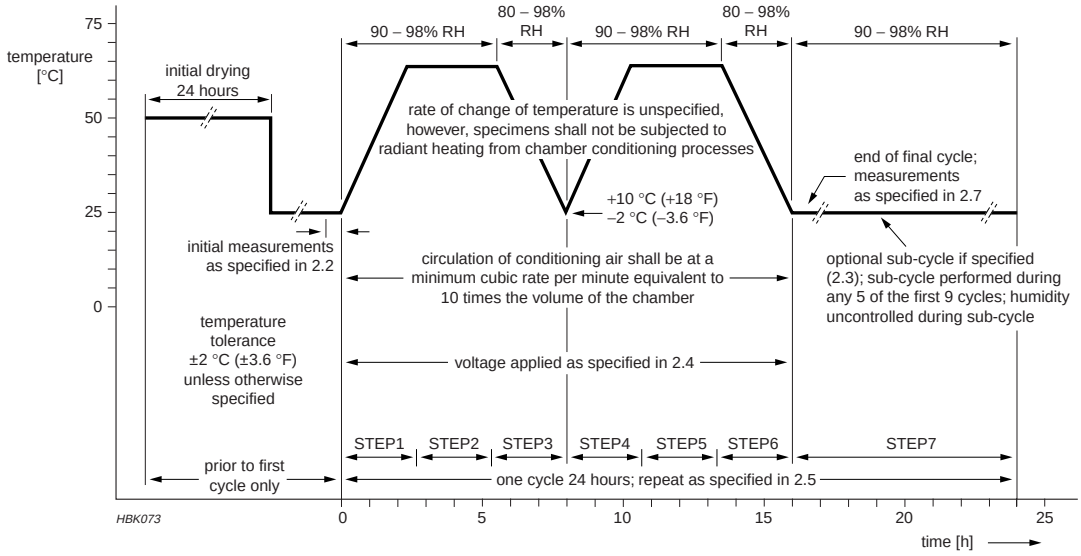


Fig. 10 Conditions by change of temperature